


<b>Search Notes</b>  	<b>Application/Control No.</b>  10034072	<b>Applicant(s)/Patent Under Reexamination</b>  SLUTSKY ET AL.
	<b>Examiner</b>  Ahshik Kim	<b>Art Unit</b>  2876

SEARCHED			
Class	Subclass	Date	Examiner
235	462.01	4/11/08	ak
	462.15	4/11/08	ak
	462.24	4/11/08	ak
	472.01	4/11/08	ak

SEARCH NOTES		
Search Notes	Date	Examiner
See attached EAST search history	3/30/04	ak
Updated Search	9/8/04	ak
Updated Search	6/4/05	ak
Updated Search	11/28/05	ak
Updated Search	4/11/08	ak
Updated Search	10/13/08	ak

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	Same as above (see Searched)	10/13/08	ak

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